

Issue Classification		Application/Control No.	Applicant(s)/Patent under Reexamination
		10/500,241	SCHON ET AL.
Examiner		Art Unit	
	Ching Chang	3748	

ORIGINAL			CROSS REFERENCE(S)					
CLASS	SUBCLASS	CLASS	SUBCLASS (ONE SUBCLASS PER BLOCK)					
123	90.44	123	90.39	90.45				
INTERNATIONAL CLASSIFICATION								
F 01	L	1 118						
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		/						
		/						

Ching Chang 04/06/05
(Assistant Examiner) (Date)

Dawn Bauer 4/11/05
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(Primary Examiner) *Thomas Denion* (Date) *4/6/04*

Total Claims Allowed: **20**

<input type="checkbox"/> O.G. Print Claim(s)	<input type="checkbox"/> O.G. Print Fig.
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<input type="checkbox"/> Claims renumbered in the same order as presented by applicant		<input type="checkbox"/> CPA		<input type="checkbox"/> T.D.		<input type="checkbox"/> R.1.47	
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